Search Notes

Application/Control No.
10/510,400
Examiner
Henok G. Heyi

Applicant(s)/Patent under
Reexamination
SHIONO ET AL.
Art Unit

2627

	SEAR	CHED	
Class	Subclass	Date	Examiner
369	275.1	10/1/2007	нн
369	275.2	10/1/2007	нн
369	94	10/1/2007	нн
369	288	10/1/2007	. нн
369	286	10/1/2007	нн
369	284	10/1/2007	нн
430	290	10/1/2007	нн
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
369	275.2	10/1/2007	нн		
369	288	10/1/2007	нн		
430	290	10/1/2007	нн		

	DATE	EXMR
AST searched. See Printout. ISR vas relied on. Consulted primary xaminers in QEM meeting	10/1/2007	НН
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